

# UNISONIC TECHNOLOGIES CO., LTD

4N90-N Power MOSFET

## 4 Amps, 900 Volts N-CHANNEL POWER MOSFET

#### **■** DESCRIPTION

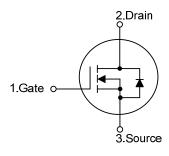
The UTC **4N90-N** is a N-channel enhancement MOSFET adopting UTC's advanced technology to provide customers with DMOS, planar stripe technology. This technology is designed to meet the requirements of the minimum on-state resistance and perfect switching performance. It also can withstand high energy pulse in the avalanche and communication mode.

The UTC **4N90-N** is particularly applied in high efficiency switch mode power supplies.

#### ■ FEATURES

- \*  $R_{DS(ON)}$  < 4.2 $\Omega$  @  $V_{GS}$ =10V,  $I_{D}$ =2A
- \* High switching speed
- \* 100% avalanche tested
- \* Improved dv/dt capability

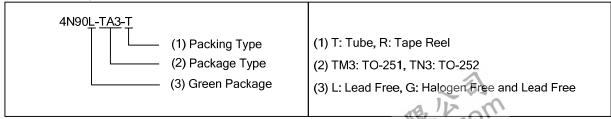
#### ■ SYMBOL



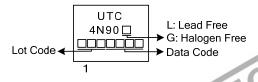
## ■ ORDERING INFORMATION

Ordering Number		Doolsons	Pin Assignment			Daakina	
Lead Free	Halogen Free	Package	1	2	3	Packing	
4N90L-TM3-T	4N90G-TM3-T	TO-251	G	D	S	Tube	
4N90L-TN3-R	4N90G-TN3-R	TO-252	G	D	S	Tape Reel	

Note: Pin Assignment: G: Gate D: Drain S: Source



## **■** MARKING



TO-251

<u>www.unisonic.com.tw</u> 1 of 6

## ■ ABSOLUTE MAXIMUM RATINGS (T<sub>C</sub>=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain to Source Voltage		$V_{DSS}$	900	V
Gate to Source Voltage		$V_{GSS}$	±30	V
Avalanche Current (Note 2)		I <sub>AR</sub>	4	Α
Continuous Drain Current	Continuous	$I_{D}$	4	Α
	Pulsed (Note 2)	I <sub>DM</sub>	16	Α
Avalanche Energy	Single Pulsed (Note 3)	E <sub>AS</sub>	240	mJ
	Repetitive (Note 2)	E <sub>AR</sub>	14	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	4.5	V/ns
Power Dissipation (T <sub>C</sub> =25°C)			54	W
Derate above 25°C		$P_D$	0.43	W/°C
Operating Junction Temperature		TJ	+150	°C
Storage Temperature		T <sub>STG</sub>	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature
- 3. L=30mH,  $I_{AS}$ =4A,  $V_{DD}$ =50V,  $R_{G}$ =25 $\Omega$ , Starting  $T_{J}$ =25 $^{\circ}$ C
- 4.  $I_{SD} \le 4A$ , di/dt  $\le 200A/\mu s$ ,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J = 25$ °C

#### **■ THERMAL DATA**

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	$\theta_{JA}$	110	°C/W	
Junction to Case	$\theta_{JC}$	2.3	°C/W	



## **ELECTRICAL CHARACTERISTICS** (T<sub>C</sub>=25°C, unless otherwise specified)

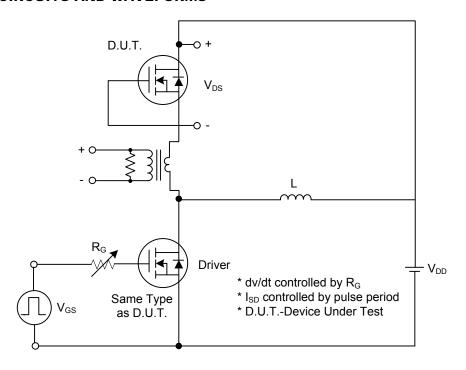
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV <sub>DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA	900			V
Breakdown Voltage Temperature Coefficient		$\Delta BV_{DSS}/\Delta T_{J}$	I <sub>D</sub> =250μA, Referenced to 25°C		1.05		V/°C
Drain-Source Leakage Current		I <sub>DSS</sub>	V <sub>DS</sub> =900V, V <sub>GS</sub> =0V			10	μΑ
			V <sub>DS</sub> =720V, T <sub>C</sub> =125°C			100	μΑ
Gate- Source Leakage Current	Forward	I <sub>GSS</sub>	$V_{GS}$ =+30V, $V_{DS}$ =0V			+100	nA
Gate- Source Leakage Current	Reverse	$I_{GSS}$	$V_{GS}$ =-30V, $V_{DS}$ =0V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$ , $I_{D}=250\mu A$	3.0		5.0	V
Drain-Source On-State Resistance		R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =2A		3.5	4.2	Ω
DYNAMIC PARAMETERS				-			
Input Capacitance		C <sub>ISS</sub>			900		pF
Output Capacitance		Coss	$V_{DS}$ =25V, $V_{GS}$ =0V,f=1.0MHz		67		pF
Reverse Transfer Capacitance		C <sub>RSS</sub>			50		pF
SWITCHING PARAMETERS				-			
Total Gate Charge		$Q_G$	\/ -E0\/ \/ -10\/   -1.3A		38		nC
Gate-Source Charge		$Q_{GS}$	$V_{DS}$ =50V, $V_{GS}$ =10V, $I_{D}$ =1.3A (Note 1,2)		7.5		nC
Gate-Drain Charge		$Q_{GD}$	(Note 1,2)		8.8		nC
Turn-ON Delay Time		t <sub>D(ON)</sub>			65		ns
Turn-ON Rise Time		t <sub>R</sub>	$V_{DD}$ =30V, $I_{D}$ =0.5A, $R_{G}$ =25 $\Omega$		56		ns
Turn-OFF Delay Time		t <sub>D(OFF)</sub>	(Note 1,2)		130		ns
Turn-OFF Fall Time		t <sub>F</sub>			50		ns
SOURCE- DRAIN DIODE RATIN	NGS AND C	HARACTERI	STICS				
Maximum Body-Diode Continuous Current		I <sub>S</sub>				4	Α
Maximum Body-Diode Pulsed Current		I <sub>SM</sub>				16	Α
Drain-Source Diode Forward Voltage		$V_{SD}$	I <sub>S</sub> =4A, V <sub>GS</sub> =0V			1.4	V

Notes: 1. Pulse Test : Pulse width≤300µs, Duty cycle≤2%

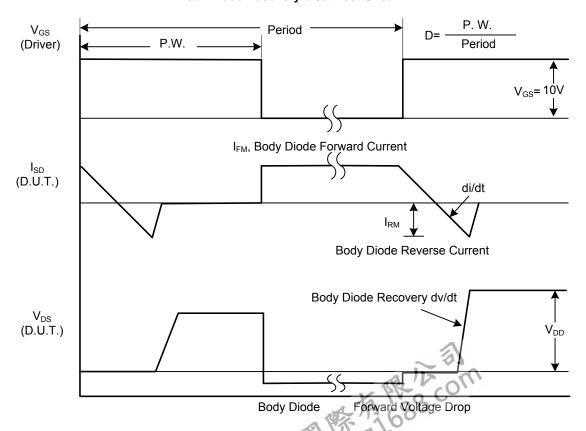


<sup>2.</sup> Essentially independent of operating temperature

#### **■ TEST CIRCUITS AND WAVEFORMS**

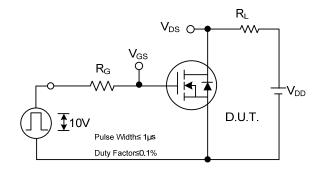


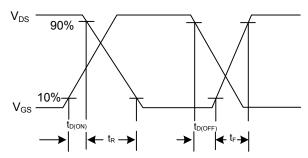
Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

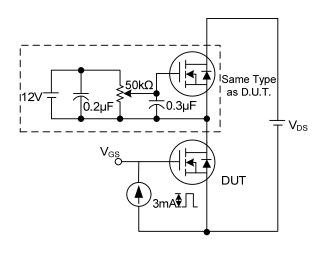
## **TEST CIRCUITS AND WAVEFORMS (Cont.)**

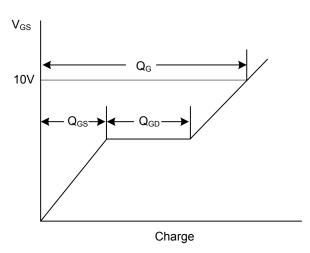




**Switching Test Circuit** 

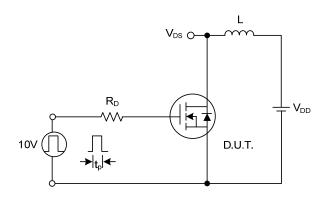
**Switching Waveforms** 

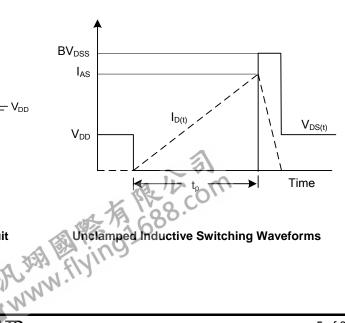




**Gate Charge Test Circuit** 

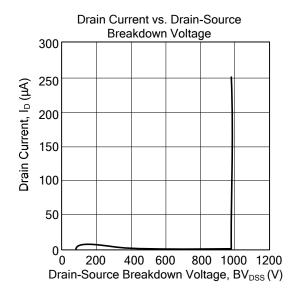
**Gate Charge Waveform** 

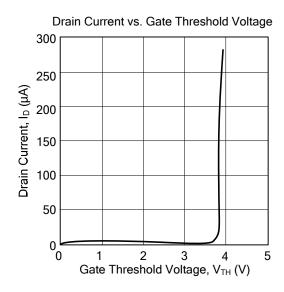


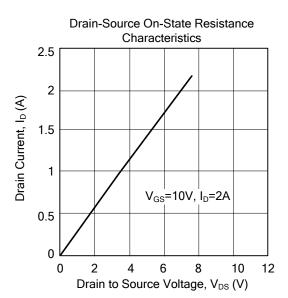


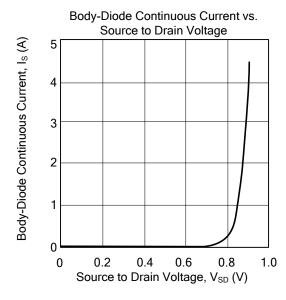
**Unclamped Inductive Switching Test Circuit** 

#### TYPICAL CHARACTERISTICS









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